

MESO Interferometry Applications

Metrology solution

Simpler, faster & more robust

Insensitive to vibrations At-wavelength metrology Parallel optics testing





MESO +

New metrology solution for easy at-wavelength testing of flat surfaces in any environment

MESO is the perfect tool for the characterization of:

- + Parallel Optics
- + Screens
- + Filters, dichroics
- + Mirrors
- + Beamsplitters
- + Windows, substrates
- + Corner cubes
- + Crystals
- + Rods, disks
- + Glass wafers
- + Displays
- + Machined surfaces
- + Windshields
- + Prisms
- + Large lenses
- + Optical systems, beam expanders

APPLICATIONS

- + In situ process control
- + Thin Parallel Optics characterization
- + Transmitted wavefront quality (TWE)
- + Surface shape & flatness measurement (RWE)
- + Large optics testing
- + Wedge measurement

FEATURES

- + Insensitive to vibrations thanks to fast single shot acquisition and the lack of need for a reference arm for comparison. It allows for a standalone setup compatible with shop floor metrology!
- + At-wavelength sample testing due to its achromatic system embedding up to 4 light sources, automatically controlled by the User Interface.
- + Insensitive to reflections from the back surface of the sample thanks to a unique patent pending method.

 No surface preparation of the sample is needed, avoiding added steps that could disturb the metrology and put the sample at risk.
- + Smart maintenance: On-site user install or replacement of sources with no opening of optical areas and no realignment needed.



SPECIFICATIONS

OPERATING SPECS

Phase point resolution Minimum exposure time

Calibrated range

Working output wavelengths

Output polarization

Operating system

680 x 500 27 μs

405 nm to 830 nm

405 nm, 488 nm, 520 nm, 635 nm, 785 nm, 830 nm, custom

optional linear, circular

high performance Dell™ computer & 24" touchscreen, Windows 10,

WAVESURF™ acquisition control & analysis software

OPTICAL SPECS

Optical configuration Test beam diameters

Optical axis

double-pass

optical zoom from 1.5" (38.1 mm) up to 6" (152 mm)

4.25" (108 mm)

MISC

Dimensions (Height x Width x Length)

Weight

Mounting configuration

Camera Interface Warranty

Vibration isolation Compressed air

Sample reflectivity

Sample min. thickness

RMS wavefront repeatability*

63 x 30 x 45 cm³

25 kg

horizontal or vertical 4096 x 3000 pixels, 10 bits

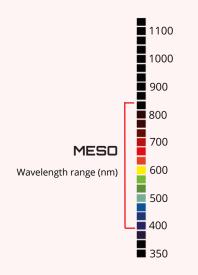
USB 3.0

1 year system & laser standard, extendable

not necessary not necessary

1% - 100 %, no attenuation required

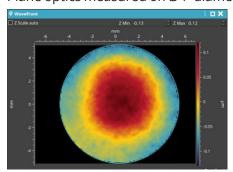
100 μm 1 nm



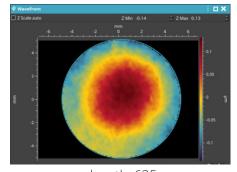
 $^{^*}$ From a set of 36 measurements on a Ø4" diameter flat mirror, each of them averaged 16 times, a synthetic reference is defined by the mean of the 18 odd measurements. The RMS wavefront repeatability is then defined by the mean RMS difference plus 2x the standard deviation of the difference between the 18 even measurements and the synthetic reference.

ACHROMATISM

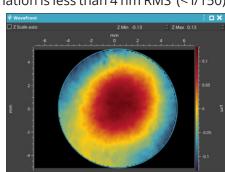
Plane optics measured on Ø4" diameter at 3 wavelengths: wavefront error variation is less than 4 nm RMS (< I/150)



wavelength: 402 nm wfe: 53 nm RMS



wavelength: 635 nm wfe: 57 nm RMS



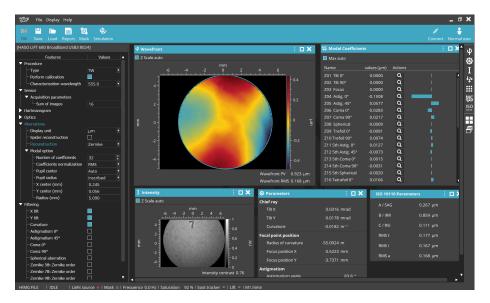
wavelength: 785 nm wfe: 57 nm RMS

SOFTWARE

WAVESURF™

Easy-to-use interface

WAVESURF[™] allows operators and engineers in manufacturing environments to perform wavefront and surface characterization of flat optics and large lenses with just a few clicks. Scripted testing procedures guide users through all the steps. It makes control easy, automated and error-proof.



- + Touchscreen interface control
- + Scripted testing procedures guide the user through all the steps
- + Automated control of up to 4 embedded wavelengths
- + Automated control of test diameter (optical zoom)
- + Complete automated test report
- + ISO10110 standard compliance
- + Data format compatible with CODE V[®] and MetroPro[™]

WHITE PAPERS

- + Shop floor measurement: vibration-proofed solutions for optical metrology
- + At-wavelength metrology for optical systems and surfaces
- + Parallel optics testing: simultaneous characterization of both optical faces in laboratory and manufacturing conditions

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